



VERY HIGH SPEED PNP POWER TRANSISTORS

COMPLEMENTARY TO THE D44VH SERIES

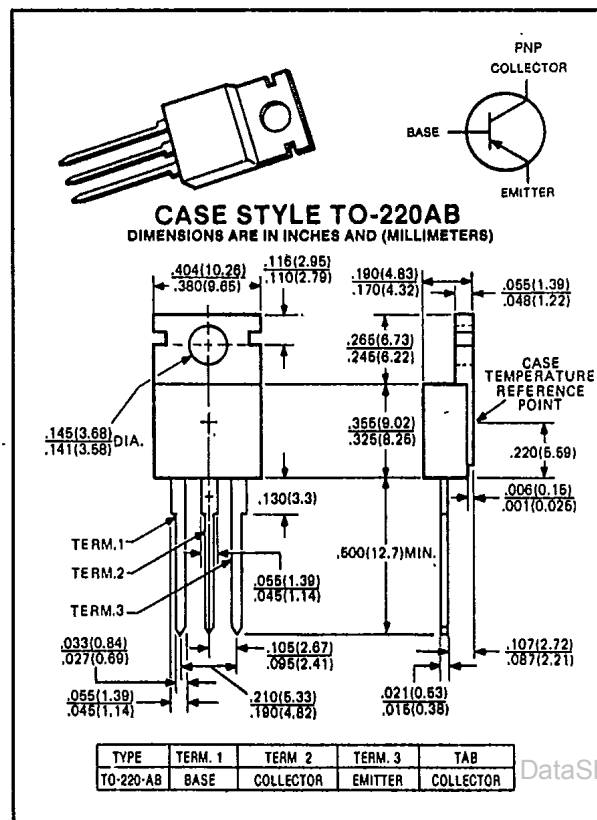
D45VH Series

-30 - -80 VOLTS
-15 AMP, 83 WATTS

The D45VH is a PNP power transistor especially designed for use in switching circuits such as switching regulators, high-frequency inverters/converters and other applications where very fast switching and low-saturation voltages are necessary. This device complements the D44VH NPN power transistor and is characterized with performance information which relates directly to switching.

Features:

- Fast Switching $t_s \leq 500$ ns resistive
 $t_f \leq 100$ ns
- Low $V_{CE(sat)} \leq 1.0V$ @ $I_C = 8A$



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maximum ratings ($T_A = 25^\circ C$) (unless otherwise specified)

RATING	SYMBOL	D45VH1	D45VH4	D45VH7	D45VH10	UNITS
Collector-Emitter Voltage	$V_{CEO(sus)}$	-30	-45	-60	-80	Volts
Collector-Emitter Voltage	V_{CEX}	-40	-55	-70	-90	Volts
Collector-Emitter Voltage	V_{CEV}	-50	-70	-80	-100	Volts
Emitter Base Voltage	V_{EBO}	-7	-7	-7	-7	Volts
Collector Current — Continuous	I_C	-15	-15	-15	-15	A
Peak ⁽¹⁾	I_{CM}	-20	-20	-20	-20	
Base Current — Continuous	I_B	-5	-5	-5	-5	A
Peak ⁽¹⁾	I_{BM}	-10	-10	-10	-10	
Total Power Dissipation @ $T_c = 25^\circ C$	P_D	83	83	83	83	Watts
@ $T_c = 100^\circ C$		33	33	33	33	
Derate above $25^\circ C$.67	.67	.67	.67	W/ $^\circ C$
Operating and Storage Junction Temperature Range	T_J, T_{STG}	-55 to +150	-55 to +150	-55 to +150	-55 to +150	$^\circ C$

thermal characteristics

Thermal Resistance, Junction to Case	$R_{\theta JC}$	1.5	1.5	1.5	1.5	$^\circ C/W$
Thermal Resistance, Junction to Ambient	$R_{\theta JA}$	75	75	75	75	$^\circ C/W$
Maximum Lead Temperature for Soldering Purpose: $\frac{1}{8}$ " from Case for 5 Seconds	T_L	235	235	235	235	$^\circ C$

(1) Pulse measurement condition $PW \leq 6.0$ ms, see Figure 14.

CHARACTERISTICS	SYMBOL	MIN	MAX	UNIT
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off characteristics⁽¹⁾

Collector-Emitter Sustaining Voltage ⁽¹⁾ ($I_C = 100\text{mA}$, $I_B = 0$) D45VH1 D45VH4 D45VH7 D45VH10	$V_{CEO(sus)}$	-30 -45 -60 -80	— — — —	V
Collector-Emitter Voltage ⁽²⁾ ($I_C = 10\text{A}$, $V_{CLAMP} = \text{Rated } V_{CEX}$, $T_C = 100^\circ\text{C}$) D45VH1 D45VH4 D45VH7 D45VH10	V_{CEX}	-40 -55 -70 -90	— — — —	V
Collector Cutoff Current ($V_{CEV} = \text{Rated Value}$, $V_{BE(off)} = 4.0\text{V}$) ($V_{CEV} = \text{Rated Value}$, $V_{BE(off)} = 4.0\text{V}$, $T_C = 100^\circ\text{C}$)	I_{CEV}	— —	-10 -100	μA
Collector Cutoff Current ($V_{CE} = \text{Rated } V_{CEV}$, $R_{BE} = 50\ \Omega$, $T_C = 100^\circ\text{C}$)	I_{CER}	—	-100	μA
Emitter Cutoff Current ($V_{EB} = -7\text{V}$, $I_C = 0$)	I_{EBO}	—	-10	μA

second breakdown

Second Breakdown with Base Forward Biased	FBSOA	SEE FIGURE 7
Second Breakdown with Base Reverse Biased	RBSOA	SEE FIGURE 8

on characteristics⁽¹⁾

DC Current Gain ($I_C = -2\text{A}$, $V_{CE} = -1\text{V}$) ($I_C = -4\text{A}$, $V_{CE} = -1\text{V}$)	h_{FE}	35 20	— —	—
Collector-Emitter Saturation Voltage ($I_C = -8\text{A}$, $I_B = -0.8\text{A}$) ($I_C = -8\text{A}$, $I_B = -0.8\text{A}$, $T_C = 100^\circ\text{C}$) ($I_C = -15\text{A}$, $I_B = -3.0\text{A}$, $T_C = 100^\circ\text{C}$)	$V_{CE(sat)}$	— — —	-1.0 -1.1 -1.5	V
Base-Emitter Saturation Voltage ($I_C = -8\text{A}$, $I_B = -0.8\text{A}$) ($I_C = -8\text{A}$, $I_B = -0.8\text{A}$, $T_C = 100^\circ\text{C}$)	$V_{BE(sat)}$	— —	-1.4 -1.4	V

dynamic characteristics

Typical

Current-Gain — Bandwidth Product ($I_C = -0.1\text{A}$, $V_{CE} = -10\text{V}$, $f_{test} = 1\text{MHz}$)	f_T	50	MHz
Output Capacitance ($V_{CB} = -10\text{V}$, $I_E = 0$, $f_{test} = 1\text{MHz}$)	C_{OB}	275	pF

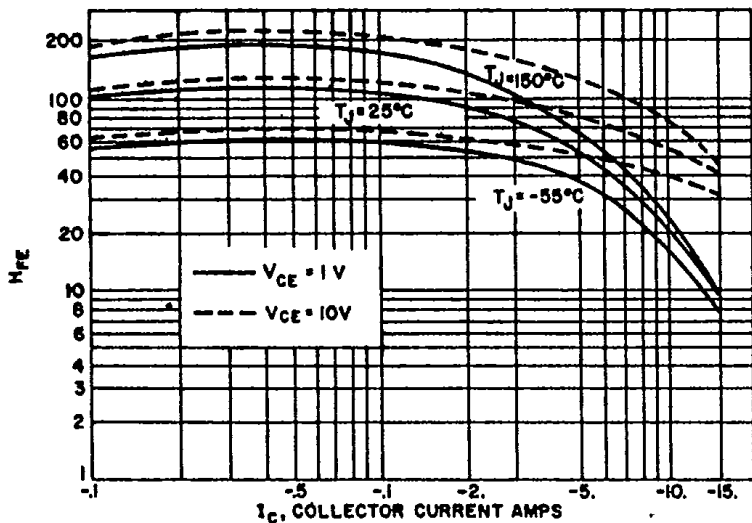
switching characteristics

Maximum

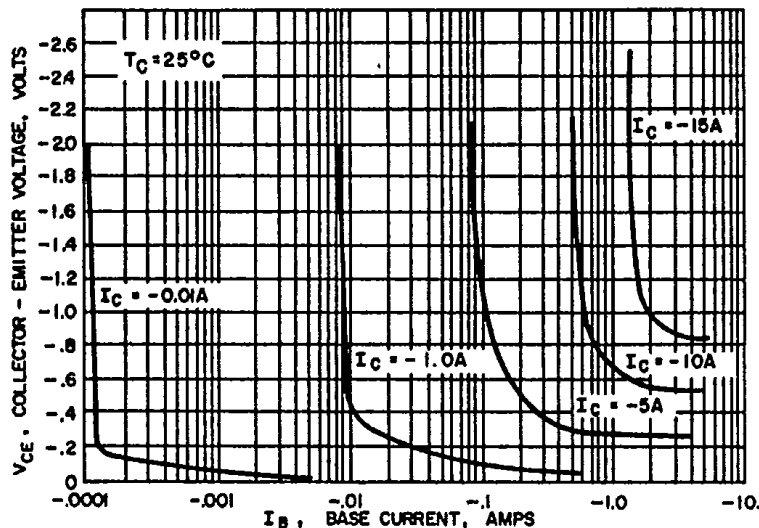
Resistive Load (See Figure 16 for Test Circuit)		T_C	25°C	100°C	
Delay Time	$V_{CC} = -20\text{V}$, $I_C = -8\text{A}$ $I_{B1} = I_{B2} = -0.8\text{A}$ $t_p = 25\ \mu\text{sec}$	t_d	50	—	nsec
Rise Time		t_r	250	—	nsec
Storage Time		t_s	500	—	nsec
Fall Time		t_f	100	—	nsec
Inductive Load, Clamped (See Figure 15 for Test Circuit)					
Storage Time	$V_{CC} = -20\text{V}$, $I_C = -8\text{A}$ $V_{CLAMP} = \text{Rated } V_{CEX}$ $I_{B1} = 0.8\text{A}$, $V_{BE(off)} = -5\text{V}$	t_s	500	600	nsec
Fall Time		t_f	300	400	nsec
			Typical		
Storage Time	$L = 200\ \mu\text{H}$	t_s	200	320	nsec
Fall Time		t_f	160	180	nsec

(1) Pulse Duration = 300 μsec , Duty Factor $\leq 2\%$.

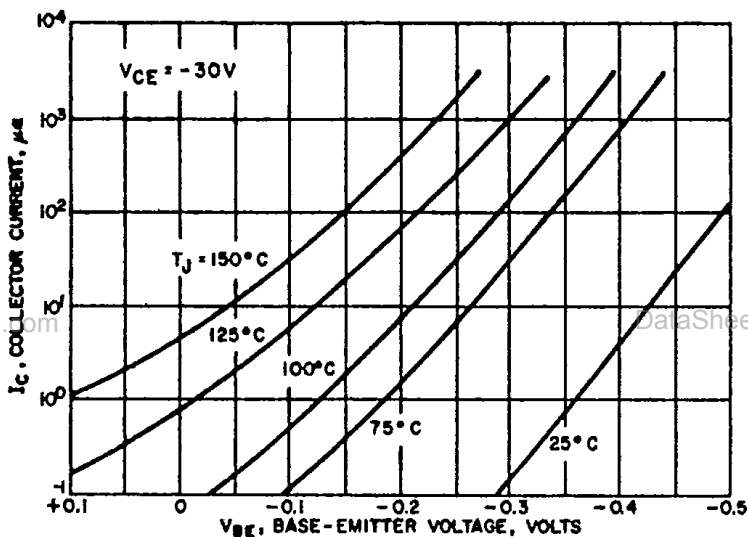
(2) See Figure 15 for Test Circuit.



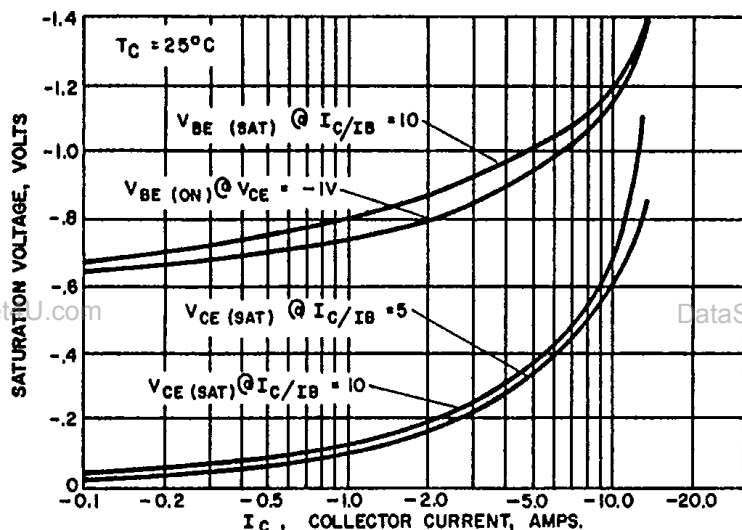
1. DC CURRENT GAIN



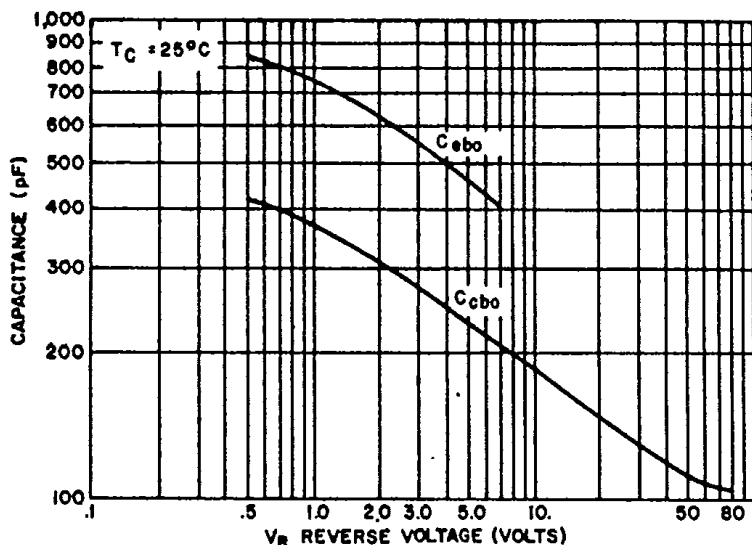
2. COLLECTOR SATURATION REGION



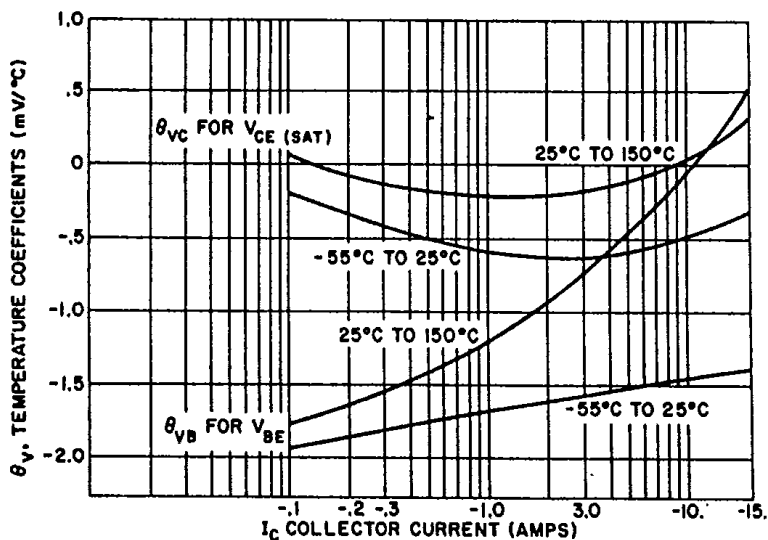
3. COLLECTOR CUTOFF REGION



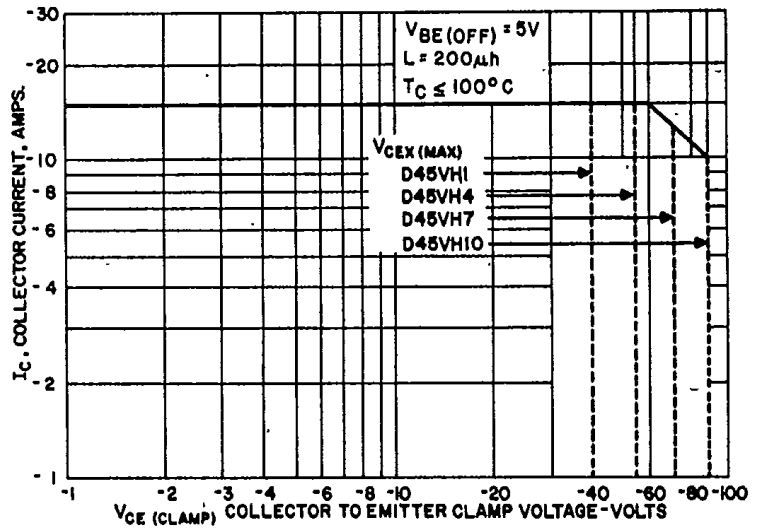
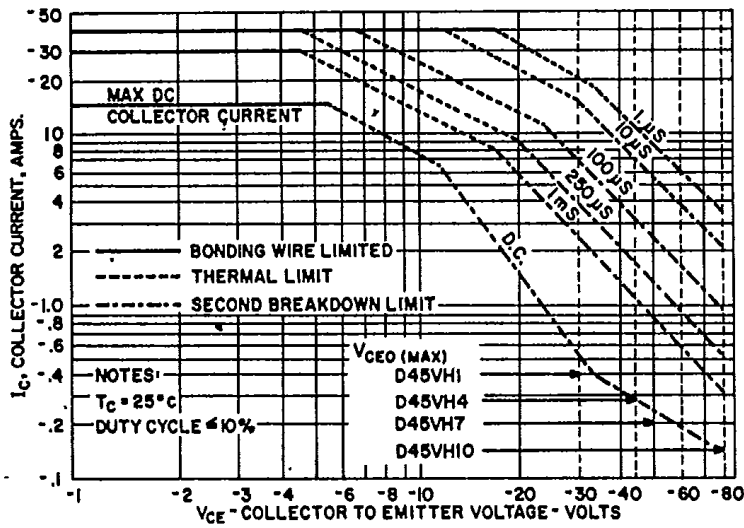
4. SATURATION VOLTAGE



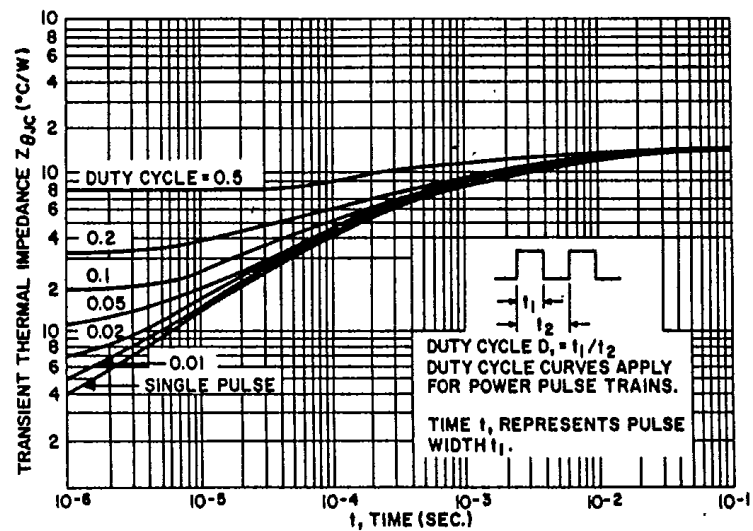
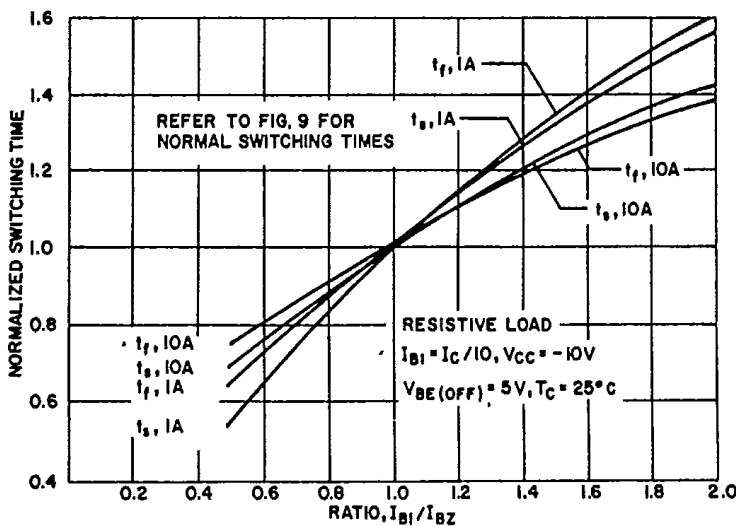
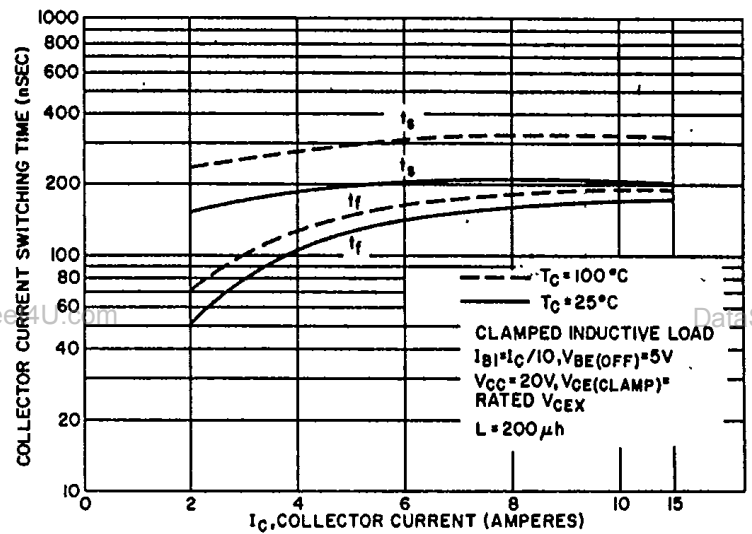
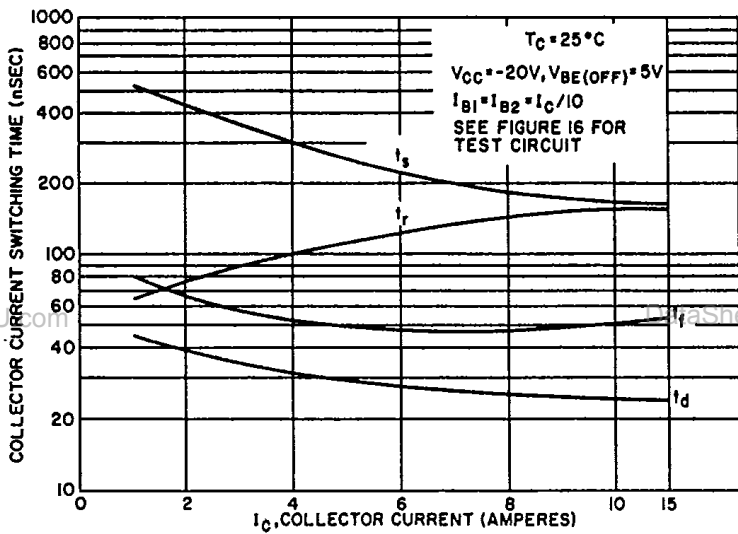
5. CAPACITANCE

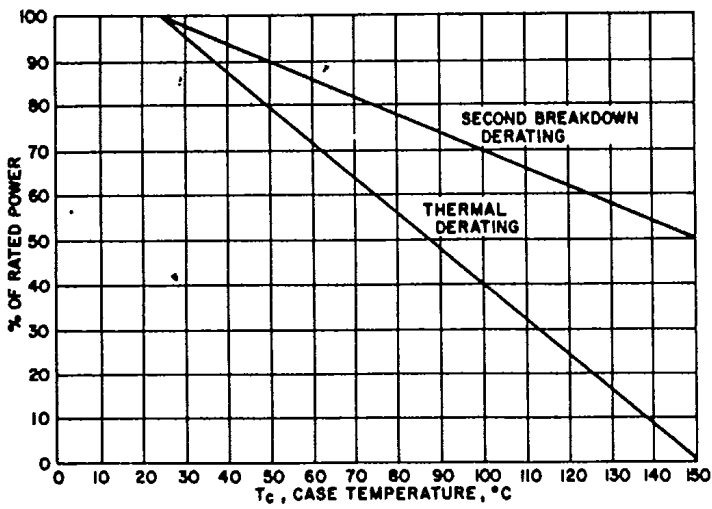


6. SATURATION VOLTAGE TEMPERATURE COEFFICIENTS

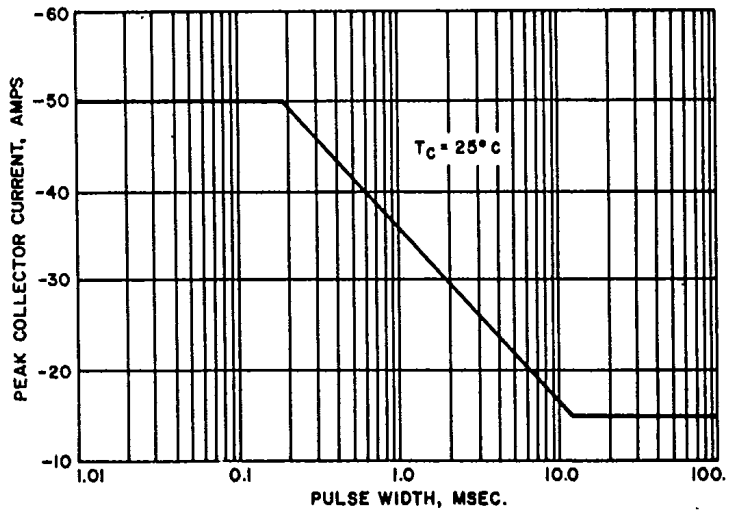


TYPICAL SWITCHING CHARACTERISTICS



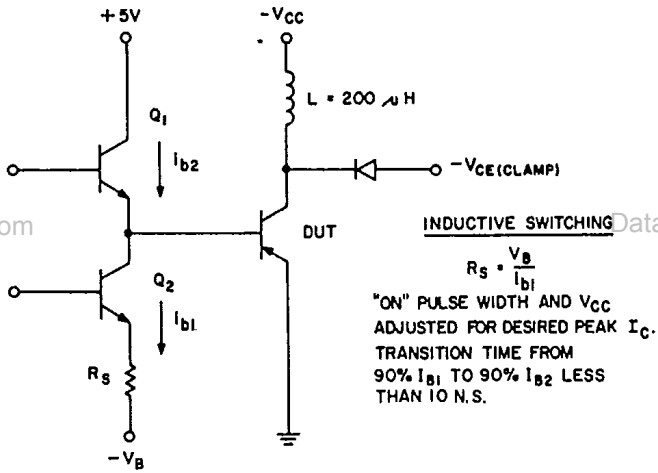


13. POWER DERATING FACTOR

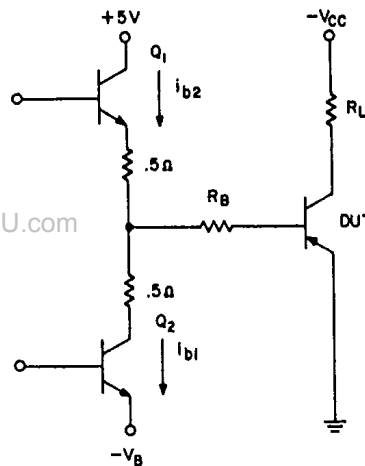


14. MAXIMUM SINGLE PULSE COLLECTOR CURRENT

TEST CIRCUITS



15. INDUCTIVE SWITCHING AND V_{CEX}



RESISTIVE SWITCHING

$$R_C = \frac{V_{CC}}{I_C}, \text{ NON-INDUCTIVE}$$

$$R_B = \frac{V_B}{I_{b1}} - 0.5$$

TRANSITION TIME 90% I_{B1} TO 90% I_{B2} LESS THAN 10 N.S.

16. RESISTIVE SWITCHING